

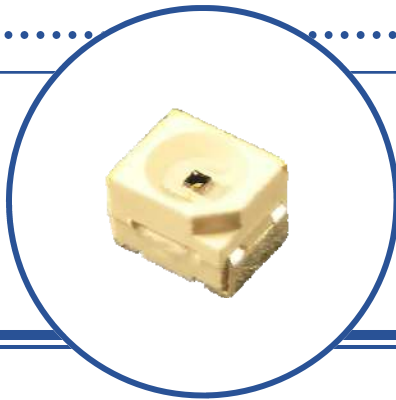
Silicon Phototransistor

OP580



Features:

- Wide acceptance angle
- Fast response time
- Plastic leadless chip carrier (PLCC)
- Moisture Sensitivity Level: MSL2 or >



Description:

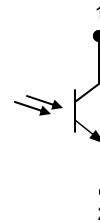
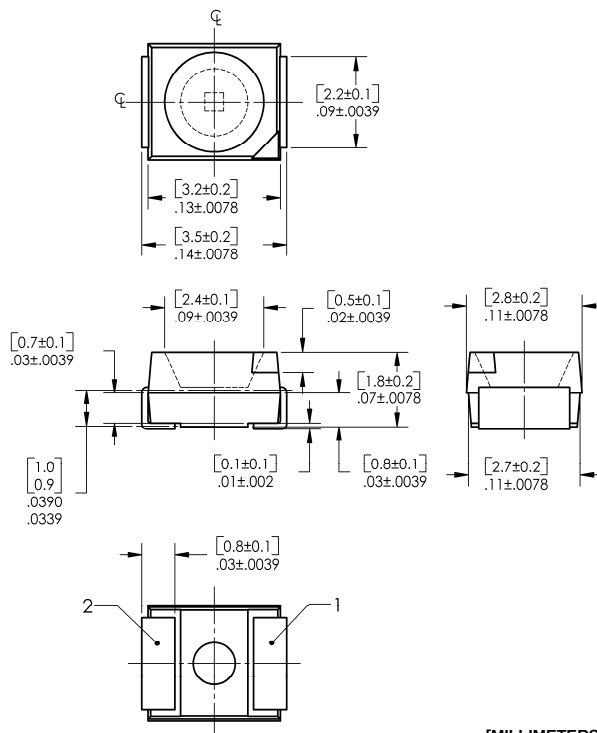
The **OP580** is an NPN silicon phototransistor mounted in a miniature SMD package. The device has a flat window lens, which enables a wide acceptance angle. It is packaged in a plastic leadless chip carrier that is compatible with most automated mounting equipment. *The OP580 is mechanically and spectrally matched to the OP280 infrared LED.*

Please refer to Application Bulletins 208 and 210 for additional design information and reliability (degradation) data.

Applications:

- Non-contact position sensing
- Machine automation
- Datum detection
- Optical encoders

Ordering Information			
Part Number	Sensor	Viewing Angle	Lead Length
OP580	Phototransistor	100°	N/A



Pin #	Transistor
1	Collector
2	Emitter



RoHS

OPTEK reserves the right to make changes at any time in order to improve design and to supply the best product possible.

Absolute Maximum Ratings ($T_A=25^\circ\text{C}$ unless otherwise noted)

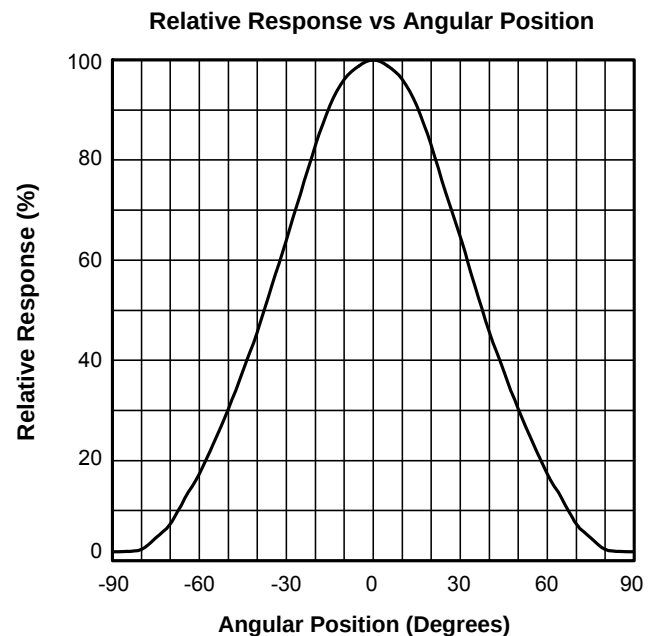
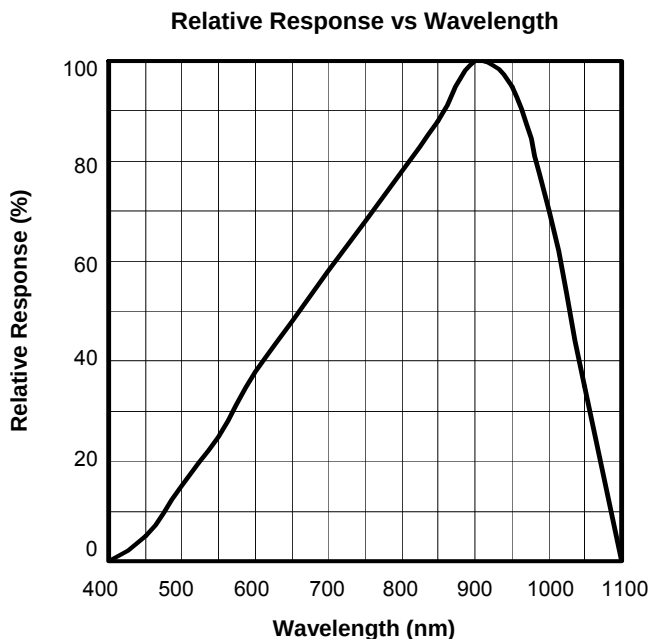
Storage Temperature Range	-40° C to +85° C
Operating Temperature Range	-25° C to +85° C
Lead Soldering Temperature	260° C ⁽¹⁾
Collector-Emitter Voltage	30 V
Emitter-Collector Voltage	5 V
Collector Current	20 mA
Power Dissipation	75 mW ⁽²⁾

Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNITS	TEST CONDITIONS
$I_{C(ON)}$	On-State Collector Current	1.0	-	-	mA	$V_{CE} = 5.0\text{ V}$, $E_E = 5.0\text{ mW/cm}^2$ ⁽³⁾
$V_{CE(SAT)}$	Collector-Emitter Saturation Voltage	-	-	0.4	V	$I_C = 100\text{ }\mu\text{A}$, $E_E = 2.0\text{ mW/cm}^2$ ⁽³⁾
I_{CE0}	Collector-Emitter Dark Current	-	-	100	nA	$V_{CE} = 5.0\text{ V}$, $E_E = 0$ ⁽⁴⁾
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage	30	-	-	V	$I_C = 100\text{ }\mu\text{A}$
$V_{(BR)ECO}$	Emitter-Collector Breakdown Voltage	5	-	-	V	$I_E = 100\text{ }\mu\text{A}$
t_r, t_f	Rise Time , Fall Time	-	15	-	μs	$I_C = 1\text{ mA}$, $R_L = 1\text{ K}\Omega$

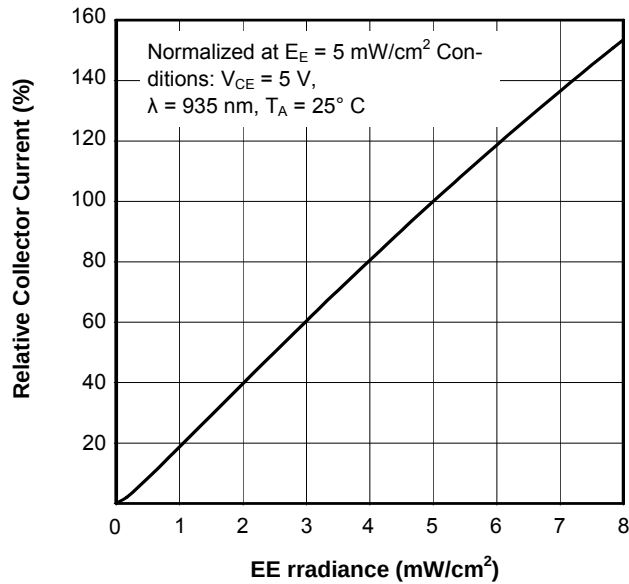
Notes:

1. Solder time less than 5 seconds at temperature extreme.
2. Derate linearly at 2.17 mW/° C above 25° C.
3. $E_{E(APT)}$ is an unfiltered GaAs LED with a peak emission wavelength of 935 nm and a radiometric intensity level which varies less than 10% over the entire lens surface of the phototransistor being tested.
4. To calculate typical collector dark current in μA , use the formula $I_{CE0} = 10^{(0.04 T_A - 3.4)}$ where T_A is the ambient temperature in ° C.

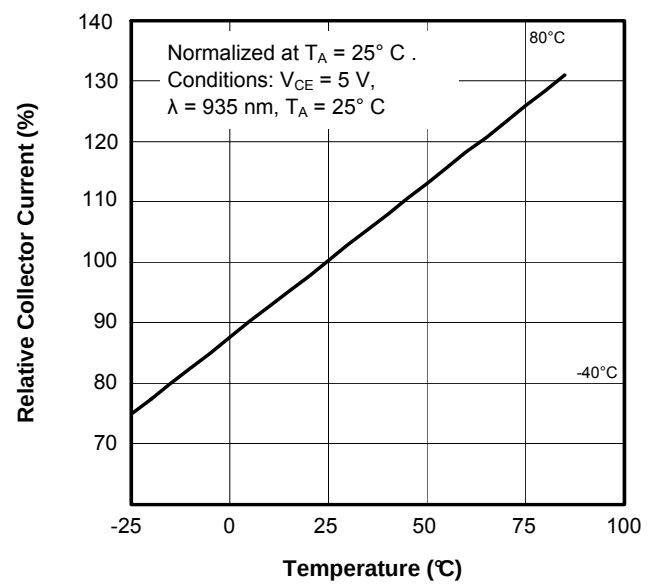


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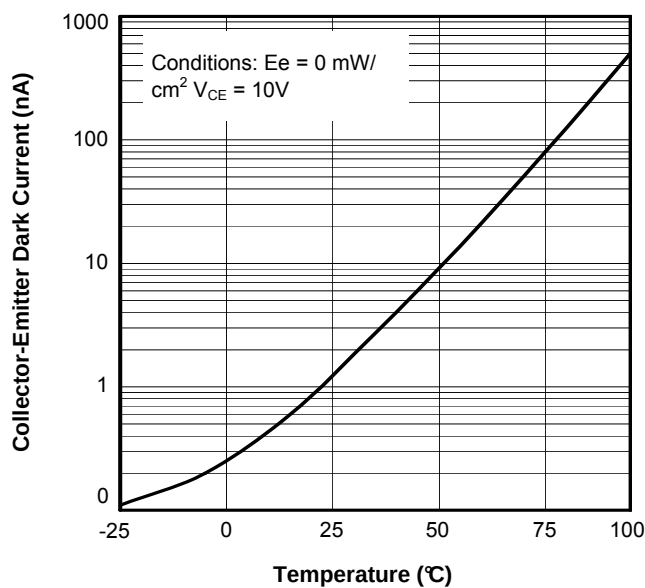
Relative On-State Collector Current vs Irradiance



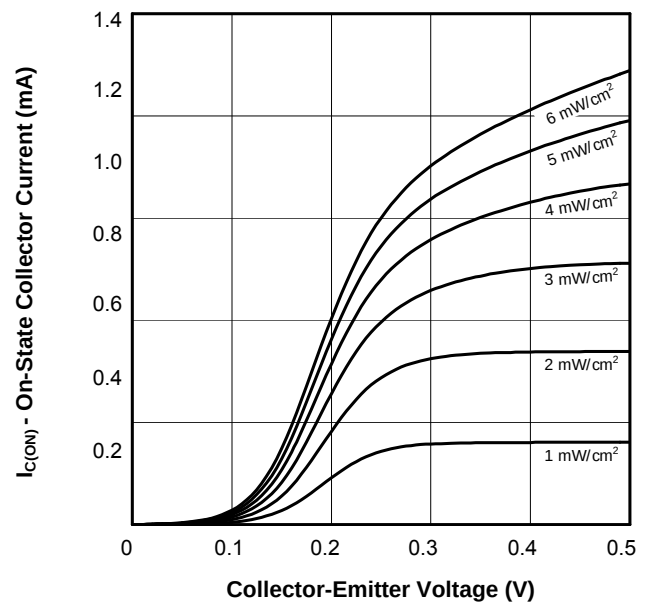
Relative On-State Collector Current vs Temperature



Collector-Emitter Dark Current vs Temperature



Relative On-State Collector Current vs Collector-Emitter Voltage



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